

MOSFETs Silicon N-channel MOS (U-MOSIX-H)

# TPH3R704PL

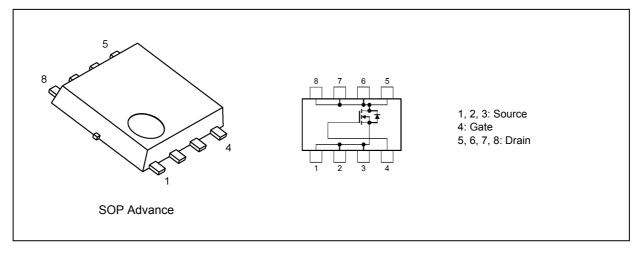
#### 1. Applications

- · High-Efficiency DC-DC Converters
- Switching Voltage Regulators
- · Motor Drivers

#### 2. Features

- (1) High-speed switching
- (2) Small gate charge:  $Q_{SW} = 8.1 \text{ nC (typ.)}$
- (3) Small output charge:  $Q_{oss} = 20.2 \text{ nC (typ.)}$
- (4) Low drain-source on-resistance:  $R_{DS(ON)} = 3.0 \text{ m}\Omega$  (typ.) ( $V_{GS} = 10 \text{ V}$ )
- (5) Low leakage current:  $I_{DSS}$  = 10  $\mu A$  (max) ( $V_{DS}$  = 40 V)
- (6) Enhancement mode:  $V_{th} = 1.4 \text{ to } 2.4 \text{ V } (V_{DS} = 10 \text{ V}, I_D = 0.2 \text{ mA})$

#### 3. Packaging and Internal Circuit





#### 4. Absolute Maximum Ratings (Note) (Ta = 25 °C unless otherwise specified)

Characteristics				Rating	Unit
Drain-source voltage			V <sub>DSS</sub>	40	V
Gate-source voltage			$V_{GSS}$	±20	
Drain current (DC)	(T <sub>c</sub> = 25 °C)	(Note 1)	I <sub>D</sub>	92	Α
Drain current (pulsed)	(t = 100 μs)	(Note 1)	I <sub>DP</sub>	260	Α
Power dissipation	(T <sub>c</sub> = 25 °C)		P <sub>D</sub>	81	W
Power dissipation		(Note 2)	P <sub>D</sub>	3.0	W
Power dissipation		(Note 3)	P <sub>D</sub>	0.96	W
Single-pulse avalanche energy		(Note 4)	E <sub>AS</sub>	14	mJ
Single-pulse avalanche current		(Note 4)	I <sub>AS</sub>	92	Α
Channel temperature			T <sub>ch</sub>	175	°C
Storage temperature	_		T <sub>stg</sub>	-55 to 175	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### 5. Thermal Characteristics

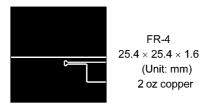
Characteristics	Symbol	Max	Unit		
Channel-to-case thermal resistance	(T <sub>c</sub> = 25 °C)		R <sub>th(ch-c)</sub>	1.83	°C/W
Channel-to-ambient thermal resistance	(T <sub>a</sub> = 25 °C)	(Note 2)	R <sub>th(ch-a)</sub>	50	
Channel-to-ambient thermal resistance	(T <sub>a</sub> = 25 °C)	(Note 3)	R <sub>th(ch-a)</sub>	156	

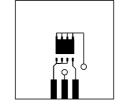
Note 1: Ensure that the channel temperature does not exceed 175 °C.

Note 2: Device mounted on a glass-epoxy board (a), Figure 5.1

Note 3: Device mounted on a glass-epoxy board (b), Figure 5.2

Note 4:  $V_{DD}$  = 32 V,  $T_{ch}$  = 25 °C (initial), L = 1.3  $\mu$ H,  $I_{AS}$  = 92 A





FR-4 25.4 × 25.4 × 1.6 (Unit: mm) 2 oz copper

Fig. 5.1 Device Mounted on a Glass-Epoxy Board (a)

Fig. 5.2 Device Mounted on a Glass-Epoxy Board (b)

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.



#### 6. Electrical Characteristics

### 6.1. Static Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±0.1	μА
Drain cut-off current	I <sub>DSS</sub>	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V	_	_	10	
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	40	_		٧
Drain-source breakdown voltage (Note 5)	V <sub>(BR)DSX</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = -20 V	25	_	_	
Gate threshold voltage	$V_{th}$	$V_{DS} = 10 \text{ V}, I_{D} = 0.2 \text{ mA}$	1.4	_	2.4	
Drain-source on-resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 13 A	_	4.2	6.0	mΩ
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 46 A	_	3.0	3.7	

Note 5: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

#### 6.2. Dynamic Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	1910	2500	pF
Reverse transfer capacitance	$C_{rss}$		_	41	80	
Output capacitance	C <sub>oss</sub>		_	470	_	
Gate resistance	r <sub>g</sub>	_	_	0.9	1.4	Ω
Switching time (rise time)	t <sub>r</sub>	See Fig. 6.2.1	_	5.3	_	ns
Switching time (turn-on time)	t <sub>on</sub>		_	14.7	_	
Switching time (fall time)	t <sub>f</sub>		_	6.2	_	
Switching time (turn-off time)	t <sub>off</sub>		_	24	_	

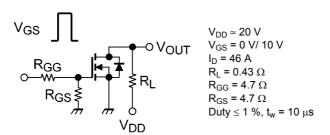


Fig. 6.2.1 Switching Time Test Circuit

### 6.3. Gate Charge Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus	$Q_g$	$V_{DD} \approx 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 46 \text{ A}$	_	27		nC
gate-drain)		$V_{DD} \approx 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 13 \text{ A}$	_	13.3		
Gate-source charge 1	Q <sub>gs1</sub>	$V_{DD} \approx 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 46 \text{ A}$	_	7.7		
Gate-drain charge	$Q_{gd}$		_	4.2	_	
Gate switch charge	$Q_{SW}$		_	8.1	_	
Output charge	$Q_{oss}$	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1MHz	_	20.2	_	

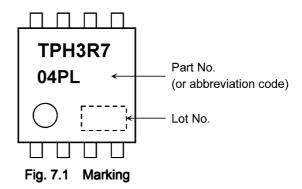


# 6.4. Source-Drain Characteristics ( $T_a = 25$ °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Reverse drain current (pulsed) (Note 6)	I <sub>DRP</sub> (t = 100 μs)		1	ı	260	Α
Diode forward voltage	V <sub>DSF</sub>	I <sub>DR</sub> = 92 A, V <sub>GS</sub> = 0 V	_	_	-1.2	V
Reverse recovery time	t <sub>rr</sub>	V <sub>R</sub> = 20 V, I <sub>DR</sub> = 23 A, V <sub>GS</sub> = 0	-	28	_	ns
Reverse recovery charge	Q <sub>rr</sub>	$V$ , - $dI_{DR}/dt = 100 A/\mu s$		18.2	_	nC

Note 6: Ensure that the channel temperature does not exceed 175 °C.

### 7. Marking





#### 8. Characteristics Curves (Note)

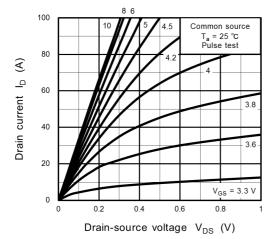
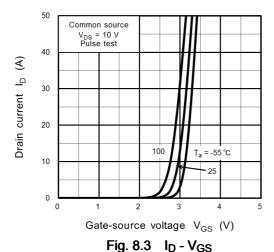


Fig. 8.1 I<sub>D</sub> - V<sub>DS</sub>



Drain-source on-resistance  $R_{DS(ON)}$  (m $\Omega$ ) 10 /<sub>GS</sub> = 10 V Common source T<sub>a</sub> = 25 ℃ Pulse test 0.1 - 0.1

100

Drain current  $I_D$  (A) Fig. 8.5 R<sub>DS(ON)</sub> - I<sub>D</sub>

10

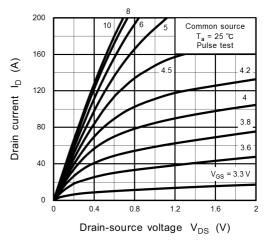


Fig. 8.2 I<sub>D</sub> - V<sub>DS</sub>

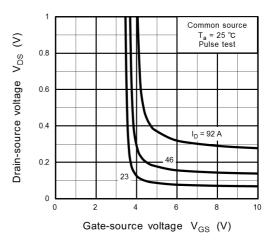


Fig. 8.4 V<sub>DS</sub> - V<sub>GS</sub>

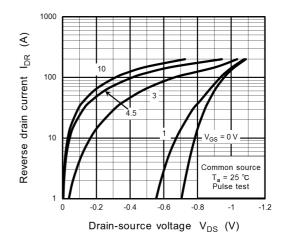


Fig. 8.6 IDR - VDS



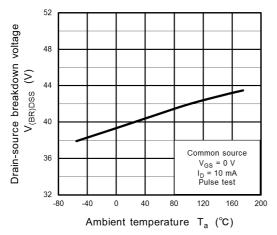


Fig. 8.7 V<sub>(BR)DSS</sub> - T<sub>a</sub>

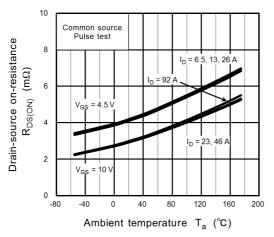


Fig. 8.9 R<sub>DS(ON)</sub> - T<sub>a</sub>

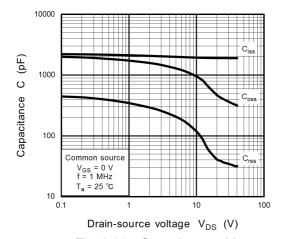


Fig. 8.11 Capacitance - V<sub>DS</sub>

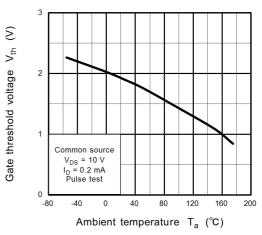


Fig. 8.8 V<sub>th</sub> - T<sub>a</sub>

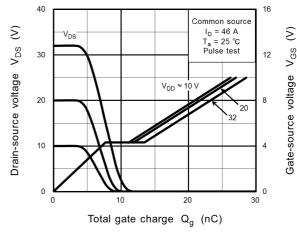


Fig. 8.10 Dynamic Input/Output Characteristics

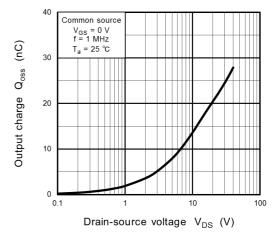


Fig. 8.12 Qoss - VDS



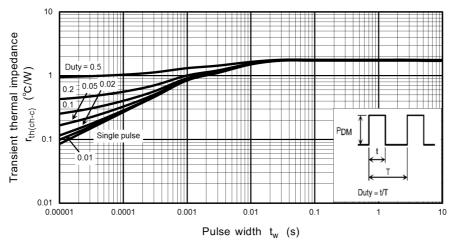


Fig. 8.13 r<sub>th</sub> - t<sub>w</sub> (Guaranteed Maximum)

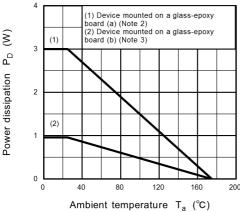


Fig. 8.14 P<sub>D</sub> - T<sub>a</sub> (Guaranteed Maximum)

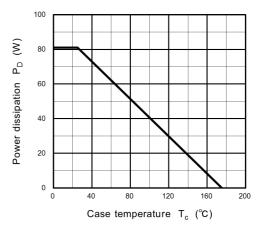


Fig. 8.15 P<sub>D</sub> - T<sub>c</sub> (Guaranteed Maximum)

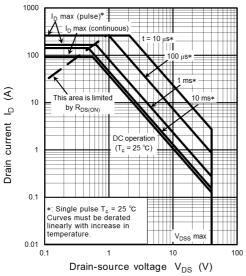


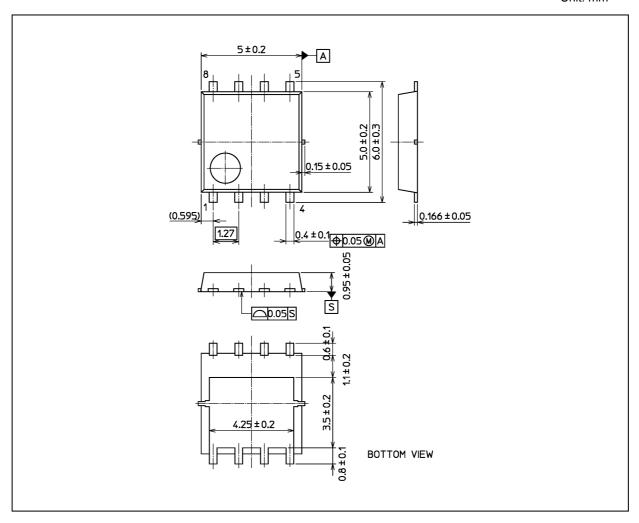
Fig. 8.16 Safe Operating Area (Guaranteed Maximum)

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



### **Package Dimensions**

Unit: mm



Weight: 0.070 g (typ.)

Package Name(s)	
TOSHIBA: 2-5Q1S	
Nickname: SOP Advance	



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